

Search Notes

Application/Control No.

10/563,441

Examiner

Louis K. Huynh

Applicant(s)/Patent under
Reexamination

RIETJENS ET AL.

Art Unit

3721

SEARCHED

Class	Subclass	Date	Examiner
493	59 227 228 240 355	5/14/2007	LH
53	412 133.8	5/14/2007	LH
219	121.67	5/14/2007	LH
219	121.69	5/14/2007	LH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR